

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of:

Joseph P. Downes, et al.

Group Art Unit: 1725

Examiner: S a m u e l M .
Heinrich

Serial No.: 10/617,940

Filed: July 11, 2003

For: LASER SCANNING METHOD AND SYSTEM FOR
MARKING ARTICLES SUCH AS PRINTED CIRCUIT
BOARDS, INTEGRATED CIRCUITS AND THE LIKE

Attorney Docket No.: GSIL 0117 PUSA 1

**INFORMATION DISCLOSURE STATEMENT
UNDER 37 C.F.R. § 1.97(b)**

Mail Stop Amendment
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U.S. Patent & Trademark Office
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Sir:

In compliance with the duty of disclosure under 37 C.F.R. § 1.56 and §§ 1.97-1.98, the references listed and identified on the attached Forms PTO/SB08A and/or SB08B are being submitted herewith for consideration by the Examiner. This Statement is being filed in accordance with 37 C.F.R. § 1.97(b).

While this Statement is being filed in compliance with the duty of disclosure,

CERTIFICATE OF MAILING UNDER 37 C.F.R. § 1.8

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February 8, 2005
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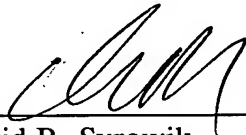
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citation of the listed references is not to be construed as an admission that any of the references are "material" as defined under 37 C.F.R. § 1.56(b).

No copies of the listed U.S. patent references or the listed U.S. patent application publication references have been included herewith pursuant to 37 C.F.R. § 1.98(a)(2). Consideration and entry into the record of the listed references is respectfully requested.

Respectfully submitted,

Joseph P. Downes, et al.

By: 
David R. Syrowik
Reg. No. 27,956
Attorney/Agent for Applicant

Date: February 8, 2005

BROOKS KUSHMAN P.C.
1000 Town Center, 22nd Floor
Southfield, MI 48075-1238
Phone: 248-358-4400
Fax: 248-358-3351

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Substitute for Form 1449A/PTO

**INFORMATION DISCLOSURE
STATEMENT BY APPLICANT**

(use as many sheets as necessary)

Complete if Known

Application Number	10/617,940
Filing Date	July 11, 2003
First Named Inventor	Joseph P. Downes, et al.
Group Art Unit	1725
Examiner Name	Heinrich, Samuel M.
Attorney Docket Number	GSIL 0117 PUSA

Sheet

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of

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U.S. PATENT DOCUMENTS

Examiner Initials	Cite No. ¹	U.S. PATENT DOCUMENT		Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number	Kind Code ² (if known)			
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		4,710,908		Ohshima et al.	12-01-1987	
		4,820,055		Müller	04-11-1989	
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FOREIGN PATENT DOCUMENTS

Examiner Initials	Cite No. ¹	Foreign Patent Document			Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T ⁶
		Office ³	Number ⁴	Kind Code ⁵ (if known)				
		WO	03/092069	A1	EO Technics Co.	11-06-2003		
		WO	01/61275		GSI Lumonics, Inc.	08-23-2001		
		WO	00/64622		GSI Lumonics Inc.	11-02-2000		

Examiner Signature		Date Considered	
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

¹ Unique citation designation number. ² See attached Kinds of U.S. Patent Documents. ³ Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). ⁴ For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document.

⁵ Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. ⁶ Applicant is to place a check mark here if English language Translation is attached.



Substitute for Form 1449B/PTO INFORMATION DISCLOSURE STATEMENT BY APPLICANT (use as many sheets as necessary)			Complete if Known		
			Application Number	10/617,940	
			Filing Date	July 11, 2003	
			First Named Inventor	Joseph P. Downes, et al.	
			Group Art Unit	1725	
			Examiner Name		
Sheet	2	of	2	Attorney Docket Number	GSIL 0117 PUSA 1

OTHER PRIOR ART -- NON PATENT LITERATURE DOCUMENTS

Examiner Initials *	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²
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		PCT International Preliminary Examination Report, dated 15 Mar 2004, pp. 1-4	
		PCT International Preliminary Examination Report, dated 28 Aug 2003, pp. 1-4	

Examiner Signature		Date Considered	
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